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Application/Control	No. Applicant(s)/Patent und Reexamination	er
10/506,980	DELACHE ET AL.	_
Examiner	Art Unit	
Kristen C Matter	3771	

SEARCHED			
Class	Subclass	Date	Examiner
128	204.18, .21, .23, 205.11	2/13/2007	ксм
128	205.18	2/13/2007	ксм
128	205.23	2/13/2007	ксм
128	204.26	2/13/2007	ксм
600	533, 538	2/13/2007	ксм
600	529	2/13/2007	ксм .
UPDATED	SEARCH	9/25/07	KCM
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
PLUS search	2/13/2007	ксм
Consultation with Teena Mitchell - gave search in class 128	2/13/2007	КСМ
Consultation with Bob Nasser gave search in class 600	2/13/2007	ксм
Inventor name search	2/13/2007	КСМ
See attached EAST search notes	2/13/2007	ксм